

Our File No. ILL02-023-DIV-US

Jonathan M. Blanchard, Ph.D

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:	)	
Chang Liu, et al.	)	
Serial No. 10/670,585	)	Examiner James J. Leybourne
Filing Date: September 25, 2003		Group Art Unit No. 2881
For SCANNING PROBE MICROSCOPY PROBE AND	,	·

METHOD FOR SCANNING PROBE CONTACT

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Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

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Form PTO 1449

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Respectfully submitted,

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OCT 2 8 2004

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## INFORMATION DISCLOSURE STATEMENT

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Dear Sir:

In accordance with the provisions of 37 C.F.R. § 1.56, Applicants request that citation and examination of the references identified on the attached PTO-1449 form, be made during the course of examination of the above-referenced application for United States Letters Patent.

This application is a divisional of application of Serial No. 10/440,022. Accordingly, all information previously submitted to and/or cited by the Examiner is not provided, according to 37 C.F.R. § 1.98(d).

Since this Information Disclosure Statement is being submitted after the mailing of the first Office Action, payment of the fee set forth in 37C.F.R. §1.117(p) accompanies this submission.

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Form PTO-1449 (Rev. 8-88)	Attorney Docket No. ILL02-023-DIV-US	Serial No. 10/670,585	
	Applicant: Chang Liu, et al.		
INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)	Filing Date: September 25, 2003	Group: 2881	

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